SCDS138 - OCTOBER 2003

- Member of the Texas Instruments Widebus™ Family
- Undershoot Protection for Off-Isolation on A and B Ports Up to -2 V
- B-Port Outputs Are Precharged by Bias Voltage (BIASV) to Minimize Signal Distortion During Live Insertion and Hot-Plugging
- Supports PCI Hot Plug
- Bidirectional Data Flow, With Near-Zero Propagation Delay
- Low ON-State Resistance (r_{on}) Characteristics (r_{on} = 3 Ω Typical)
- Low Input/Output Capacitance Minimizes Loading and Signal Distortion (C_{io(OFF)} = 5.5 pF Typical)
- Data and Control Inputs Provide Undershoot Clamp Diodes
- Low Power Consumption (I_{CC} = 3 μA Max)

- V_{CC} Operating Range From 4 V to 5.5 V
- Data I/Os Support 0 to 5-V Signaling Levels (0.8-V, 1.2-V, 1.5-V, 1.8-V, 2.5-V, 3.3-V, 5-V)
- Control Inputs Can be Driven by TTL or 5-V/3.3-V CMOS Outputs
- I_{off} Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22

 2000-V Human-Body Model (A114-B, Class II)
 (A000 V Charged Davise Model (C104)
 - 1000-V Charged-Device Model (C101)
- Supports Both Digital and Analog Applications: PCI Interface, Memory Interleaving, Bus Isolation, Low-Distortion Signal Gating

	•	,	
ON		J ₂₄	V _{CC}
A1	2	23	B1
A2	[3	22	B2
A3	4	21	B3
A4	5	20	B4
A5	6	19	B5
A6	[7	18	B6
A7	8]	17	B7
A8	9	16	B8
A9	10	15	B9
A10	11	14	B10
GND	12	13	BIASV
	-		

DB, DBQ, DGV, DW, OR PW PACKAGE (TOP VIEW)

description/ordering information

The SN74CBT6800C is a high-speed TTL-compatible FET bus switch with low ON-state resistance (r_{on}), allowing for minimal propagation delay. Active Undershoot-Protection Circuitry on the A and B ports of the SN74CBT6800C provides protection for undershoot up to -2 V by sensing an undershoot event and ensuring that the switch remains in the proper OFF state. The device also precharges the B port to a user-selectable bias voltage (BIASV) to minimize live-insertion noise.



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SCDS138 - OCTOBER 2003

description/ordering information (continued)

The SN74CBT6800C is a 10-bit bus switch with a single output-enable (ON) input. When ON is low, the 10-bit bus switch is ON, and the A port is connected to the B port, allowing bidirectional data flow between ports. When ON is high, the 10-bit bus switch is OFF, and a high-impedance state exists between the A and B ports. The B port is precharged to BIASV through the equivalent of a 10-k Ω resistor when \overline{ON} is high, or if the device is powered down ($V_{CC} = 0 V$).

During insertion (or removal) of a card into (or from) an active bus, the card's output voltage may be close to GND. When the connector pins make contact, the card's parasitic capacitance tries to force the bus signal to GND, creating a possible glitch on the active bus. This glitching effect can be reduced by using a bus switch with precharged bias voltage (BIASV) of the bus switch equal to the input threshold voltage level of the receivers on the active bus. This method will ensure that any glitch produced by insertion (or removal) of the card will not cross the input threshold region of the receivers on the active bus, minimizing the effects of live-insertion noise.

This device is fully specified for partial-power-down applications using Ioff. The Ioff feature ensures that damaging current will not backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down, \overline{ON} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

TA	PACKAG	Eţ	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
		Tube	SN74CBT6800CDW	ODTODOOO	
	SOIC – DW	Tape and reel	SN74CBT6800CDWR	CBT6800C	
		Tube	SN74CBT6800CDB	CT6800C	
-40°C to 85°C	SSOP – DB	Tape and reel	SN74CBT6800CDBR		
-40 C 10 85 C	SSOP (QSOP) – DBQ	Tape and reel	SN74CBT6800CDBQR	CBT6800C	
		Tube	SN74CBT6800CPW	CT6800C	
	TSSOP – PW	Tape and reel	SN74CBT6800CPWR		
	TVSOP – DGV	Tape and reel	SN74CBT6800CDGVR	CT6800C	

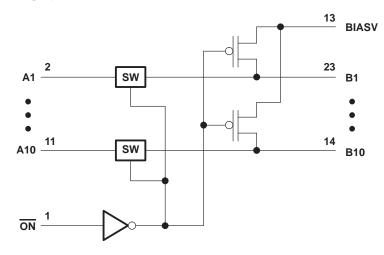
ORDERING INFORMATION

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

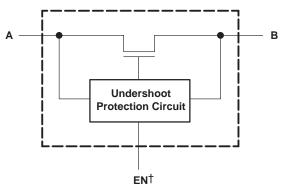
FUNCTION TABLE										
INPUT ON	INPUT/OUTPUT A	FUNCTION								
L	В	A port = B port								
н	Z	Disconnect B port = BIASV								



logic diagram (positive logic)



simplified schematic, each FET switch (SW)



 $^{\dagger}\,\text{EN}$ is the internal enable signal applied to the switch.



SCDS138 - OCTOBER 2003

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}		
Bias supply voltage range, BIASV		
Control input voltage range, VIN (see Notes 1 a	ind 2)	–0.5 V to 7 V
Switch I/O voltage range, V _{I/O} (see Notes 1, 2, a	and 3)	–0.5 V to 7 V
Control input clamp current, I _{IK} (V _{IN} < 0)		
I/O port clamp current, $I_{I/OK}$ ($V_{I/O} < 0$)		–50 mA
ON-state switch current, II/O (see Note 4)		±128 mA
Continuous current through V _{CC} or GND termin	nals	±100 mA
Package thermal impedance, θ_{JA} (see Note 5):	DB package	63°C/W
	DBQ package	61°C/W
	DGV package	
	DW package	46°C/W
	PW package	88°C/W
Storage temperature range, T _{stg}		. −65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltages are with respect to ground unless otherwise specified.

- 2. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- 3. VI and VO are used to denote specific conditions for $V_{I/O}$.
- 4. II and IO are used to denote specific conditions for $I_{I/O}$.
- 5. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 6)

		MIN	MAX	UNIT
VCC	Supply voltage	4	5.5	V
BIASV	Bias supply voltage	0	V _{CC}	V
VIH	High-level control input voltage	2	5.5	V
VIL	Low-level control input voltage	0	0.8	V
V _{I/O}	Data input/output voltage	0	5.5	V
Т _А	Operating free-air temperature	-40	85	°C

NOTE 6: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004. BIASV is a supply voltage, not a control input.



SCDS138 - OCTOBER 2003

5

10

PAR	AMETER		MIN	TYP†	MAX	UNIT		
VIK	Control inputs	V _{CC} = 4.5 V,	I _{IN} = -18 mA				-1.8	V
VIKU	Data inputs	V _{CC} = 5 V,	0 mA > I _I \ge -50 mA, V _{IN} = V _{CC} or GND,	Switch OFF			-2	V
V _{O(USP)} ‡	:	$V_{CC} = BIASV = 5 V,$	$I_I = -10 \text{ mA},$ $V_{IN} = V_{CC} \text{ or GND},$	Switch OFF	3			V
VO	B port	$V_{CC} = 0 V,$	$BIASV = V_X,$	IO = 0	V _X -0.1		$V_{\mathbf{X}}$	V
IIN	Control inputs	V _{CC} = 5.5 V,	$V_{IN} = V_{CC} \text{ or } GND$				±1	μΑ
IO	B port	V _{CC} = 4.5 V,	BIASV = 2.4 V, V _O = 0,	Switch OFF, V _{IN} = V _{CC} or GND		0.25		mA
IOZ§		V _{CC} = 5.5 V,	$V_{O} = 0$ to 5.5 V, $V_{I} = 0$,	Switch OFF, V _{IN} = V _{CC} or GND			±10	μA
l _{off}		$V_{CC} = 0,$	$V_{O} = 0$ to 5.5 V,	$V_{\parallel} = 0$			10	μΑ
ICC		V _{CC} = 5.5 V,	$I_{I/O} = 0,$ $V_{IN} = V_{CC} \text{ or GND},$	Switch ON or OFF			3	μΑ
∆ICC [¶]	Control inputs	V _{CC} = 5.5 V,	One input at 3.4 V,	Other inputs at V_{CC} or GND			2.5	mA
C _{in}	Control inputs	$V_{IN} = 3 V \text{ or } 0$				4		pF
C _{io(OFF)}	A port	$V_{I/O} = 3 V \text{ or } 0,$	Switch OFF,	$V_{IN} = V_{CC}$ or GND		5.5		pF
C _{io(ON)}		V _{I/O} = 3 V or 0,	Switch ON,	$V_{IN} = V_{CC}$ or GND		13.5		pF
		$V_{CC} = 4 V,$ TYP at $V_{CC} = 4 V$	V _I = 2.4 V,	I _O = -15 mA		8	12	
ron [#]				IO = 64 mA		3	6	Ω
		V _{CC} = 4.5 V	$V_{I} = 0$	I _O = 30 mA		3	6	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

 V_{IN} and I_{IN} refer to control inputs. $V_{I},\,V_{O},\,I_{I},\,\text{and}\,I_{O}$ refer to data pins.

[†] All typical values are at $V_{CC} = 5 V$ (unless otherwise noted), $T_A = 25^{\circ}C$.

 $V_{O(USP)} = A$ -port undershoot static protection.

§ For I/O ports, the parameter I_{OZ} includes the input leakage current.

 \P This is the increase in supply current for each input that is at the specified voltage level, rather than V_{CC} or GND.

V_I = 2.4 V,

[#] Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

 $I_{O} = -15 \text{ mA}$

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

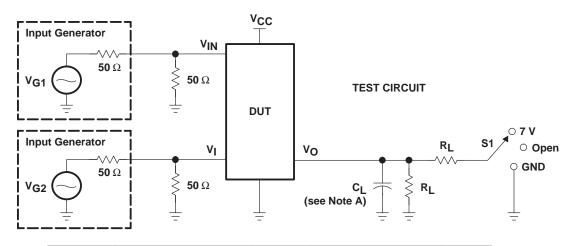
PARAMETER	TEST CONDITIONS	FROM	TO	V _{CC} = 4 V		V _{CC} = 5 V ± 0.5 V		UNIT
	CONDITIONS	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	
t _{pd}		A or B	B or A		0.24		0.15	ns
^t PZH	BIASV = GND	OE	A co D		6.2	1.5	5.9	
tPZL	BIASV = 3 V	OE	A or B		6.2	1.5	5.9	ns
^t PHZ	BIASV = GND	OE	A or B		5.6	1.5	6.2	ns
^t PLZ	BIASV = 3 V	UE	AUB		5.6	1.5	6.2	115

The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

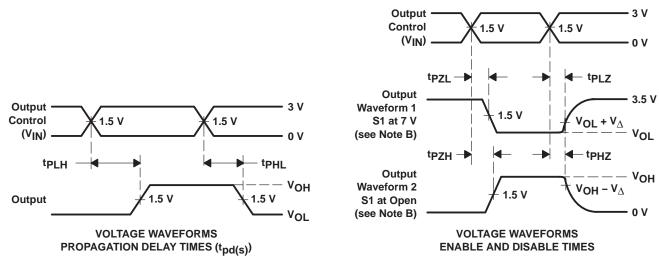


SCDS138 - OCTOBER 2003

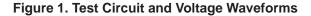
PARAMETER MEASUREMENT INFORMATION



TEST	VCC	S1	RL	VI	CL	v_Δ
^t pd(s)	$\begin{array}{c} 5~V\pm0.5~V\\ 4~V \end{array}$	Open Open	500 Ω 500 Ω	V _{CC} or GND V _{CC} or GND	50 pF 50 pF	
^t PLZ ^{/t} PZL	$\begin{array}{c} 5 \text{ V} \pm 0.5 \text{ V} \\ 4 \text{ V} \end{array}$	7 V 7 V	500 Ω 500 Ω	GND GND	50 pF 50 pF	0.3 V 0.3 V
^t PHZ ^{/t} PZH	$\begin{array}{c} 5 \text{ V} \pm 0.5 \text{ V} \\ 4 \text{ V} \end{array}$	Open Open	500 Ω 500 Ω	V _{CC} V _{CC}	50 pF 50 pF	0.3 V 0.3 V



- NOTES: A. CL includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_Q = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. $t_{PI 7}$ and t_{PHZ} are the same as t_{dis} .
 - F. tpzL and tpzH are the same as ten.
 - G. tpLH and tpHL are the same as tpd(s). The tpd propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
 - H. All parameters and waveforms are not applicable to all devices.







26-Aug-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74CBT6800CDBQRE4	ACTIVE	SSOP	DBQ	24		TBD	Call TI	Call TI	-40 to 85	CBT6800C	Samples
SN74CBT6800CDBQRG4	ACTIVE	SSOP	DBQ	24		TBD	Call TI	Call TI	-40 to 85	CBT6800C	Samples
SN74CBT6800CDGVR	ACTIVE	TVSOP	DGV	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CT6800C	Samples
SN74CBT6800CDGVRE4	ACTIVE	TVSOP	DGV	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CT6800C	Samples
SN74CBT6800CDGVRG4	ACTIVE	TVSOP	DGV	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CT6800C	Samples
SN74CBT6800CDW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CBT6800C	Samples
SN74CBT6800CDWE4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CBT6800C	Samples
SN74CBT6800CDWG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CBT6800C	Samples
SN74CBT6800CDWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CBT6800C	Samples
SN74CBT6800CDWRE4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CBT6800C	Samples
SN74CBT6800CDWRG4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CBT6800C	Samples
SN74CBT6800CPW	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CT6800C	Samples
SN74CBT6800CPWE4	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CT6800C	Samples
SN74CBT6800CPWG4	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CT6800C	Samples
SN74CBT6800CPWR	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CT6800C	Samples
SN74CBT6800CPWRE4	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CT6800C	Samples
SN74CBT6800CPWRG4	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CT6800C	Samples



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26-Aug-2013

⁽¹⁾ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74CBT6800CDGVR	TVSOP	DGV	24	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74CBT6800CDWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
SN74CBT6800CPWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

12-Aug-2013



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74CBT6800CDGVR	TVSOP	DGV	24	2000	367.0	367.0	35.0
SN74CBT6800CDWR	SOIC	DW	24	2000	367.0	367.0	45.0
SN74CBT6800CPWR	TSSOP	PW	24	2000	367.0	367.0	38.0

MECHANICAL DATA

PLASTIC SMALL-OUTLINE

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

DGV (R-PDSO-G**)

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



DBQ (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.

D. Falls within JEDEC MO-137 variation AE.



PW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES:

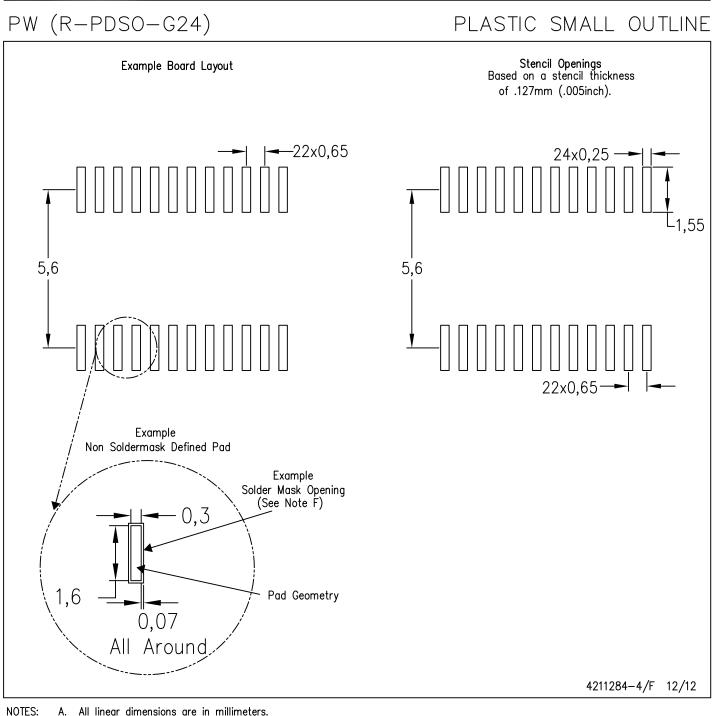
A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
B. This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153





All linear dimensions are in millimeters. Α.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations. E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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